

LM4041

1.225V Precision micropower shunt voltage reference

Description

The LM4041 is a bandgap circuit designed to achieve a precision micro-power voltage reference of 1.225 V. The device is available in the small outline SOT23 surface mount packages which is ideal for applications where space saving is important.

The LM4041 is available to 0.5% C grade for precision applications. Excellent performance is maintained over the 60 μ A to 12mA operating current range with a typical temperature coefficient of only 20ppm/ $^{\circ}$ C.

The device has been designed to be highly tolerant of capacitive loads so maintaining excellent stability.

This device offers a pin for pin compatible alternative to the LM4041 voltage reference.

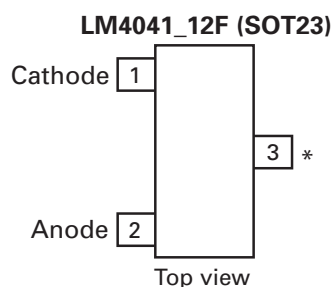
Features

- Small packages: SOT23
- No output capacitor required
- Output voltage tolerance
 - LM4041C $\pm 0.5\%$ at 25 $^{\circ}$ C
 - LM4041D $\pm 1\%$ at 25 $^{\circ}$ C
- Low output noise
(10 Hz to 10kHz) 60 μ Vrms
- Wide operating current range 60 μ A to 12mA
- Extended temperature range -40 $^{\circ}$ C to +125 $^{\circ}$ C
- Low temperature coefficient 100ppm/ $^{\circ}$ C (max)

Applications

- Battery powered equipment
- Precision power supplies
- Portable instrumentation
- Portable communications devices
- Notebook and palmtop computers
- Data acquisition systems

Pinout information



* Pin 3 must be left floating or connected to pin 2

Ordering information

25 $^{\circ}$ C tol.	Voltage (V)	Order code	Pack	Part mark	Status	Reel size	Tape width	Quantity per reel
0.5%	1.225	LM4041CFTA	SOT23	R1C	Preview	7", 180mm	8mm	3000
1%	1.225	LM4041DFTA	SOT23	R1D	Preview	7", 180mm	8mm	3000

Absolute maximum ratings

Continuous reverse current (I_{KA}) 20mA

Continuous forward current (I_{REF}) 10mA

Operating junction temperature -40°C to 150°C

Storage temperature -55°C to 150°C

Operation above the absolute maximum rating may cause device failure. Operation at the absolute maximum ratings, for extended periods, may reduce device reliability.

Unless otherwise stated voltages specified are relative to the ANODE pin.

Package thermal data

Package	Θ_{JA}	P_{DIS} $T_{amb} = 25^{\circ}C, T_J = 150^{\circ}C$
SOT23	380°C/W	330mW

Recommended operating conditions

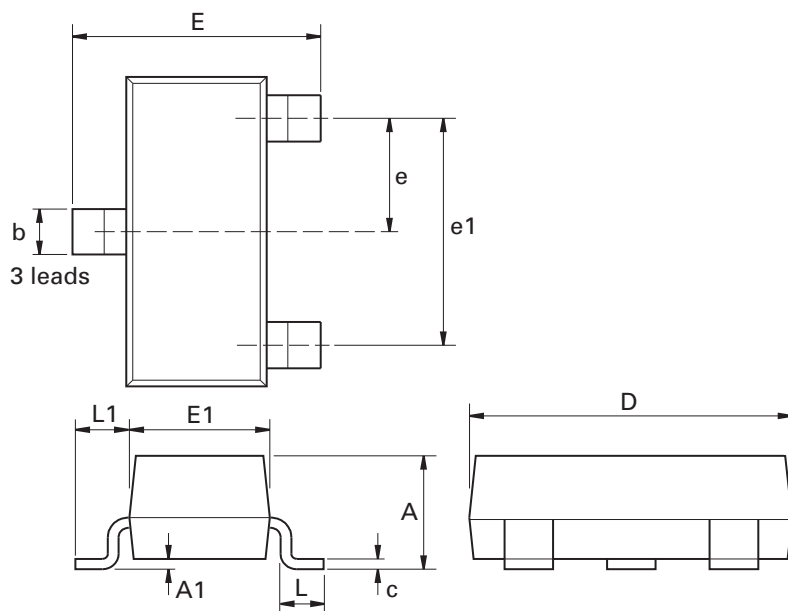
	Min.	Max.	Units
Reverse current	0.06	15	mA
Operating ambient temperature range	-40	125	°C

Electrical characteristics

Over recommended operating conditions, $T_{amb} = 25^{\circ}\text{C}$, unless otherwise stated. LM4041C and LM4041D have initial tolerances of 0.5% and 1% respectively.

Symbol	Parameter	Conditions		Typ.	LM4041C Limits	LM4041D Limits	Units
			T_{amb}				
V_{REF}	Reverse breakdown voltage	$I_R = 100\ \mu\text{A}$	25°C	1.225			V
	Reverse breakdown voltage tolerance	$I_R = 100\ \mu\text{A}$	25°C		± 6	± 12	mV
			$-40\text{ to }85^{\circ}\text{C}$		± 14	± 24	
			$-40\text{ to }125^{\circ}\text{C}$		± 18.4	± 31	
I_{RMIN}	Minimum operating current		25°C	45	60	65	μA
			$-40\text{ to }85^{\circ}\text{C}$		65	70	
			$-40\text{ to }125^{\circ}\text{C}$		68	73	
$\Delta V_R/\Delta T$	Average reverse breakdown voltage temperature coefficient	$I_R = 10\ \text{mA}$	$-40\text{ to }125^{\circ}\text{C}$	± 20			ppm/ $^{\circ}\text{C}$
		$I_R = 1\ \text{mA}$		± 15	± 100	± 150	
		$I_R = 100\ \mu\text{A}$		± 15			
$\Delta V_R/\Delta I_R$	Reverse breakdown change with current	$I_{RMIN} < I_R < 1\ \text{mA}$	25°C	0.7	1.5	2.0	mV
			$-40\text{ to }85^{\circ}\text{C}$		2.0	2.5	
			$-40\text{ to }125^{\circ}\text{C}$		2.0	2.5	
		$1\ \text{mA} < I_R < 12\ \text{mA}$	25°C	2.5	6.0	8.0	
			$-40\text{ to }85^{\circ}\text{C}$		8.0	10.0	
			$-40\text{ to }125^{\circ}\text{C}$		8.0	10.0	
Z_R	Dynamic output impedance	$I_R = 1\ \text{mA}$, $f = 120\ \text{Hz}$ $I_{AC} = 0.1I_R$		0.5	1.5	2.0	Ω
e_n	Noise voltage	$I_R = 100\ \mu\text{A}$ $10\ \text{Hz} < f < 10\ \text{kHz}$		60			μV_{RMS}
ΔV_R	Long term stability (non cumulative)	$t = 1000\ \text{Hrs}$ $I_R = 100\ \mu\text{A}$		120			ppm

Package outline - SOT23



Dim.	Millimeters		Inches		Dim.	Millimeters		Inches	
	Min.	Max.	Min.	Max.		Min.	Max.	Max.	Max.
A	-	1.12	-	0.044	e1	1.90 NOM		0.075 NOM	
A1	0.01	0.10	0.0004	0.004	E	2.10	2.64	0.083	0.104
b	0.30	0.50	0.012	0.020	E1	1.20	1.40	0.047	0.055
C	0.085	0.120	0.003	0.008	L	0.25	0.62	0.018	0.024
D	2.80	3.04	0.110	0.120	L1	0.45	0.62	0.018	0.024
e	0.95 NOM		0.0375 NOM		-	-	-	-	-

Note: Controlling dimensions are in millimeters. Approximate dimensions are provided in inches

Intentionally left blank

Definitions

Product change

Zetex Semiconductors reserves the right to alter, without notice, specifications, design, price or conditions of supply of any product or service. Customers are solely responsible for obtaining the latest relevant information before placing orders.

Applications disclaimer

The circuits in this design/application note are offered as design ideas. It is the responsibility of the user to ensure that the circuit is fit for the user's application and meets with the user's requirements. No representation or warranty is given and no liability whatsoever is assumed by Zetex with respect to the accuracy or use of such information, or infringement of patents or other intellectual property rights arising from such use or otherwise. Zetex does not assume any legal responsibility or will not be held legally liable (whether in contract, tort (including negligence), breach of statutory duty, restriction or otherwise) for any damages, loss of profit, business, contract, opportunity or consequential loss in the use of these circuit applications, under any circumstances.

Life support

Zetex products are specifically not authorized for use as critical components in life support devices or systems without the express written approval of the Chief Executive Officer of Zetex Semiconductors plc. As used herein:

A. Life support devices or systems are devices or systems which:

1. are intended to implant into the body

or

2. support or sustain life and whose failure to perform when properly used in accordance with instructions for use provided in the labelling can be reasonably expected to result in significant injury to the user.

B. A critical component is any component in a life support device or system whose failure to perform can be reasonably expected to cause the failure of the life support device or to affect its safety or effectiveness.

Reproduction

The product specifications contained in this publication are issued to provide outline information only which (unless agreed by the company in writing) may not be used, applied or reproduced for any purpose or form part of any order or contract or be regarded as a representation relating to the products or services concerned.

Terms and Conditions

All products are sold subjects to Zetex' terms and conditions of sale, and this disclaimer (save in the event of a conflict between the two when the terms of the contract shall prevail) according to region, supplied at the time of order acknowledgement.

For the latest information on technology, delivery terms and conditions and prices, please contact your nearest Zetex sales office or visit: www.zetex.com

Quality of product

Zetex is an ISO 9001 and TS16949 certified semiconductor manufacturer.

To ensure quality of service and products we strongly advise the purchase of parts directly from Zetex Semiconductors or one of our regionally authorized distributors. For a complete listing of authorized distributors please visit: www.zetex.com/salesnetwork

Zetex Semiconductors does not warrant or accept any liability whatsoever in respect of any parts purchased through unauthorized sales channels.

ESD (Electrostatic discharge)

Semiconductor devices are susceptible to damage by ESD. Suitable precautions should be taken when handling and transporting devices. The possible damage to devices depends on the circumstances of the handling and transporting, and the nature of the device. The extent of damage can vary from immediate functional or parametric malfunction to degradation of function or performance in use over time. Devices suspected of being affected should be replaced.

Green compliance

Zetex Semiconductors is committed to environmental excellence in all aspects of its operations which includes meeting or exceeding regulatory requirements with respect to the use of hazardous substances. Numerous successful programs have been implemented to reduce the use of hazardous substances and/or emissions.

All Zetex components are compliant with the RoHS directive, and through this it is supporting its customers in their compliance with WEEE and ELV directives.

Product status key:

"Preview"	Future device intended for production at some point. Samples may be available
"Active"	Product status recommended for new designs
"Last time buy (LTB)"	Device will be discontinued and last time buy period and delivery is in effect
"Not recommended for new designs"	Device is still in production to support existing designs and production
"Obsolete"	Production has been discontinued

Datasheet status key:

"Draft version"	This term denotes a very early datasheet version and contains highly provisional information, which may change in any manner without notice.
"Provisional version"	This term denotes a pre-release datasheet. It provides a clear indication of anticipated performance. However, changes to the test conditions and specifications may occur, at any time and without notice.
"Issue"	This term denotes an issued datasheet containing finalized specifications. However, changes to specifications may occur, at any time and without notice.

Zetex sales offices

Europe	Americas	Asia Pacific	Corporate Headquarters
Zetex GmbH Kustermann-park Balanstraße 59 D-81541 München Germany Telefon: (49) 89 45 49 49 0 Fax: (49) 89 45 49 49 49 europe.sales@zetex.com	Zetex Inc 700 Veterans Memorial Highway Hauppauge, NY 11788 USA Telephone: (1) 631 360 2222 Fax: (1) 631 360 8222 usa.sales@zetex.com	Zetex (Asia Ltd) 3701-04 Metroplaza Tower 1 Hing Fong Road, Kwai Fong Hong Kong Telephone: (852) 26100 611 Fax: (852) 24250 494 asia.sales@zetex.com	Zetex Semiconductors plc Zetex Technology Park, Chadderton Oldham, OL9 9LL United Kingdom Telephone: (44) 161 622 4444 Fax: (44) 161 622 4446 hq@zetex.com

© 2006 Published by Zetex Semiconductors plc